Influence of the annealing atmosphere on the structural properties of FePt thin films

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FePt thin films with a thickness of 30 nm were deposited by dc magnetron sputtering at room temperature onto SiO2(100 nm)/Si(100) substrates. These films were post-annealed in a temperature range of 500 °C to 900 °C for 30 s in three different atmospheres—N2, Ar, and forming gas (Ar+H2 (3 vol. %)). Irrespective of the annealing atmosphere, the chemically ordered L10 FePt phase has formed after annealing at 500 °C. Higher annealing temperatures in N2 or Ar atmosphere resulted in a strong increase in grain size and surface roughness but also in the appearance of a pronounced (001) texture in the FePt films. However, these films show the presence of iron oxide. In contrast, annealing in forming gas atmosphere suppressed the oxidation process and resulted in a reduced grain size and lower surface roughness. However, no (001)—but a strong (111)—texture was obtained after annealing at 700 °C, which might be related to the reduced unit cell tetragonality and incorporation of hydrogen to the FePt lattice. Thus, this study clearly demonstrates that the oxygen/hydrogen content plays an important role in controlling the crystallographic orientation during post-annealing.

I. INTRODUCTION

Chemically ordered L10 FePt is a potential material candidate for ultra-high density magnetic data storage due to its large magnetic anisotropy, high saturation magnetization, and high corrosion resistance.1–4 Typically, the L10 FePt phase forms at elevated temperatures when starting from the initially disordered A1 phase. However, industrial application of FePt films requires (i) reduction of the L10 phase for forming FeN enhances the diffusivity of Fe and Pt during annealing13–15 and thus improves the L10 ordering. In contrast, hydrogen atoms can occupy octahedral interstitial sites in the FePt lattice which causes local strain48 influencing the ordering kinetics as well. In addition, the fast diffusion rate of hydrogen atoms will in turn induce an increased diffusion rate of Fe and Pt atoms promoting the L10 ordering.16–18 Furthermore, hydrogen will suppress oxidation processes. In this regard, Leistner et al.19 have shown that annealing of rather thick FePt films in H2 atmosphere results in lower surface roughness. However, no (001)—but a strong (111)—texture was obtained after annealing at 700 °C, which might be related to the reduced unit cell tetragonality and incorporation of hydrogen to the FePt lattice. Thus, this study clearly demonstrates that the oxygen/hydrogen content plays an important role in controlling the crystallographic orientation during post-annealing.

II. EXPERIMENTAL PROCEDURE

FePt thin films of 30 nm thickness were deposited by dc magnetron sputtering at room temperature using individual Fe and Pt targets onto thermally oxidized Si(100) substrates with a 100-nm-thick amorphous SiO2 layer. The Ar sputter pressure was adjusted to 3.5 × 10−3 mbar for all depositions and the composition of the Fe40Pt50 alloy was verified.

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by Rutherford backscattering spectroscopy. Post-annealing of the film samples up to 900 °C was carried out in flowing N₂, Ar, and forming gas atmosphere at a flowing speed of 0.2 l/min with annealing times of 30 s using a fixed heating rate of 10 °C/s. The thickness of the FePt films was determined by x-ray reflectometry measurements. The structural properties were analyzed using a x-ray diffractometer (Bruker D8 Discover) equipped with a 2-dimensional (2D) detector and with a scintillation counter using Cu Kα radiation. The average grain size was estimated from XRD data using the Scherrer equation, while the analysis of the film texture was carried out using the March-Dollase model. In this model, the correction of the intensity of any diffraction peak is performed by introducing an effective repetition factor. In the case, when there is no (001)-texture present, the texture coefficient ($\tau$) is equal to 1, and $\tau = 0$ when all grains are (001)-oriented, while in intermediate cases $\tau$ takes values between 1 and 0. Furthermore, XPS was used to analyze the chemical state of Fe and Pt, and the surface roughness was investigated by atomic force microscopy (AFM).

III. RESULTS AND DISCUSSION

After post-annealing the FePt films at temperatures up to 900 °C in different atmospheres, 2D-XRD data were taken. The 2D-XRD patterns are presented in Fig. 1 revealing already after post-annealing at 500 °C in all three annealing atmospheres the presence of superstructure (001) reflections and the splitting into the tetragonal (200) and (002) peaks confirming that the L1₀ phase has formed. However, it is apparent that after annealing at 700 °C in N₂ and Ar atmosphere, the (001) peak intensity becomes much stronger than the intensity of the (111) reflection. Furthermore, the (001) intensity distribution is not uniform along the diffraction ring, which indicates the preferable orientation of the grains along the 001 direction. In contrast, post-annealing in forming gas atmosphere does not lead to the pronounced (001)-texture formation; here, a strong (111)-texture is observed.

Based on the evaluation of the intensity ratio of the (001) and (111) peaks (Fig. 2), the (001)-texture coefficients were extracted as summarized in Fig. 3 as function of annealing temperature for the different gas atmospheres. It shows that grains with preferred (001)-orientation were

FIG. 1. 2D-XRD images of 30-nm-thick FePt films after annealing at different temperatures in three different atmospheres: (a) N₂, (b) Ar, and (c) Ar + H₂ (3 vol. %).

FIG. 2. XRD integral intensity ratio of the (001) and (111) intensity peaks versus annealing temperature in different gas atmospheres.
formed best after post-annealing in N₂ and Ar atmosphere at 700 °C. Further increase of the annealing temperature leads to grain agglomeration combined with the stabilization of the (111)-orientation exhibiting the lowest surface energy. As already mentioned, post-annealing in forming gas atmosphere did not lead to the formation of (001)-texture instead a strong (111)-texture is obtained.

The determination of the a- and c-lattice parameter allows visualizing the strain induced in the grains by the annealing process. As expected the c-axis is substantially contracted, while the a-axis is expanded in agreement with the bulk values of fully L1₀ ordered FePt resulting in a tetragonal distortion as presented by the c/a values shown in Fig. 4. Here, the films annealed in forming gas reveal a somewhat smaller tetragonal distortion most likely due to the incorporation of hydrogen to the FePt lattice.

The average grain size as a function of the annealing temperature is shown in Fig. 5. Annealing of films at temperatures higher than 700 °C in N₂ or Ar atmosphere leads to a significant increase in grain size due to grain agglomeration resulting in the stabilization of the (111) orientation. This grain growth process is strongly suppressed when annealed in forming gas showing an averaged grain size of about 20 nm at 900 °C, which is two times smaller than compared with annealing in N₂ and Ar atmosphere. In turn, this leads also to a reduced root mean square (rms) surface roughness as extracted from AFM imaging (Fig. 6).

In order to get some insight on the influence of hydrogen in particular on the oxidation process of the film samples during annealing, XPS spectra were taken around the Fe 2p and Pt 4f peaks. Fig. 7 shows the Fe 2p and Pt 4f XPS spectra of FePt films after post-annealing in different atmospheres at 800 °C. After annealing in H₂-containing atmosphere, the Fe 2p peak appears at about 707.4 eV, which corresponds to the bulk value for pure iron. After annealing in N₂ and Ar atmosphere, this peak shifts to 711.3 eV indicating the presence of iron oxide (i.e., Fe₂O₃). The Pt 4f peak positions are close to their expected bulk value known from literature and only a small shift of 0.6 eV is observed for the sample post annealed in N₂.
The observed differences in the structural properties of FePt films after post-annealing in different atmospheres can be explained by the influence of oxygen and hydrogen. The larger tetragonality in FePt after annealing in Ar and N$_2$ atmosphere might indicate the penetration of oxygen (which is present in inert gases and in the residual atmosphere) into the film and the formation of Fe oxides as confirmed by XPS investigations. This distortion adds elastic stress to the system which is the origin of tensile in-plane strain favoring the growth of (001)-oriented grains with the longer axis of the fct lattice pointing in the direction of the strain.  

In contrast, the presence of hydrogen drastically reduces the amount of oxygen in the gas atmosphere. Furthermore, hydrogen is incorporated into the FePt lattice and reduces the tetragonality of the L1$_0$ unit cell thus the driving force for (001) texture formation is slightly reduced. Moreover, hydrogen promotes the kinetics of ordering and thus lowers the ordering temperature. Both effects, the simultaneous reduction of oxygen and the incorporation of hydrogen to the FePt lattice, are the key ingredients for the (111) texture formation as also pointed out in Ref. 23.

IV. CONCLUSIONS

We can conclude that annealing in N$_2$ and Ar atmosphere at 700°C leads to a pronounced (001) texture formation of the L1$_0$ ordered FePt films. In addition, a strong oxidation of the film samples as evidenced by XPS investigations was detected. Furthermore, for these films a significant increase in grain size and surface roughness was observed. In contrast, annealing in forming gas atmosphere suppressed the oxidation process and resulted in a reduced grain size and lower surface roughness. However, no (001)-but a strong (111)-texture was obtained after annealing at 700°C, which might be related to the slightly reduced unit cell tetragonality and incorporation of hydrogen to the FePt lattice. Thus, this study clearly demonstrates that the oxygen/hydrogen content plays an important role in controlling the crystallographic orientation during post-annealing.

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